

CE EMC Test Report

(EN 50155 & EN 50121-3-2)

Report No.: CEBDBO-WTW-P21050463-1

Test Model: EVS-2000

("X" can be 0-9, A-Z or blank for marketing purposes)

Received Date: May 12, 2021

Test Date: May 18 to Aug. 11, 2021

Issued Date: Aug. 23, 2021

Applicant: Vecow Co., Ltd.

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Table of Contents

Release	Control Record	. 4
1 Cert	tificate of Conformity	. 5
2 Sum	nmary of Test Results	. 6
2.1 2.2 2.3	Performance Criteria Measurement Uncertainty Modification Record	9
3 Gen	eral Information	10
3.1 3.2 3.3 3.4 3.5	Description of EUT Features of EUT Operating Modes of EUT and Determination of Worst Case Operating Mode Test Program Used and Operation Descriptions Primary Clock Frequencies of Internal Source	.10 .11 .12
4 Con	figuration and Connections with EUT	13
4.1 4.2	Connection Diagram of EUT and Peripheral Devices Configuration of Peripheral Devices and Cable Connections	
5 Con	ducted Disturbance at Auxiliary a.c. or d.c. Power Ports	17
5.1 5.2 5.3 5.4	Limits Test Instruments Test Arrangement Test Results	.17 .18
6 Rad	liated Disturbance up to 1 GHz	21
6.1 6.2 6.3 6.4	Limits	.21 .22
7 Rad	liated Disturbance above 1 GHz	25
7.1 7.2 7.3 7.4	Limits Test Instruments Test Arrangement Test Results	.25 .26
8 Hari	monics Current Measurement	29
8.1 8.2 8.3 8.4 8.5	Limits Classification of Equipment Test Instruments Test Arrangement Test Results	.29 .29 .30
9 Volt	age Fluctuations and Flicker Measurement	31
9.1 9.2 9.3 9.4	Limits Test Instruments Test Arrangement Test Results	.31 .31
10 Elec	ctrostatic Discharge Immunity Test (ESD)	
10.1 10.2 10.3 10.4	Test Specification Test Instruments Test Arrangement Test Results	.33 .33



11 R	adio-frequency Electromagnetic Field Immunity Test (RS)	39
11.1	Test Specification	
11.2		
11.3	Test Arrangement	
11.4		
12 E	lectrical Fast Transient/Burst Immunity Test (EFT)	42
12.1	Test Specification	
12.2		
12.3	. eer /	
12.4	Test Results	44
13 S	urge Immunity Test	45
13.1	Test Specification	45
13.2	Test Instruments	45
13.3		
13.4	Test Results	46
14 In	nmunity to Conducted Disturbances Induced by RF Fields (CS)	47
14.1	Test Specification	47
14.2	Test Instruments	48
14.2 14.3	Test Instruments Test Arrangement	48 49
14.2	Test Instruments Test Arrangement	48 49
14.2 14.3 14.4	Test Instruments Test Arrangement	
14.2 14.3 14.4	Test Instruments Test Arrangement Test Results	
14.2 14.3 14.4 15 P	Test Instruments Test Arrangement Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports	
14.2 14.3 14.4 15 P 15.1	Test Instruments Test Arrangement Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4	Test Instruments Test Arrangement Test Results Fictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4 15.5	Test Instruments Test Arrangement Test Results Fictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD)	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6	Test Instruments Test Arrangement Test Results Fictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS)	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7	Test Instruments Test Arrangement Test Results Test Results Test Results Test Results Test Results Test Arrangements Test Arrangements	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7 15.8	Test Instruments Test Arrangement Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS) Fast Transients (EFT) Surge	
14.2 14.3 14.4 15 P 15.1 15.2 15.3 15.4 15.5 15.6 15.7 15.8 15.9	Test Instruments Test Arrangement Test Results ictures of Test Arrangements Conducted Disturbance at Auxiliary a.c. or d.c. power ports Radiated Disturbance up to 1 GHz Radiated Disturbance above 1 GHz Harmonics Current, Voltage Fluctuations and Flicker Measurement Electrostatic Discharge Immunity Test (ESD) Radio-frequency Electromagnetic Field Immunity Test (RS) Fast Transients (EFT) Surge	



Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P21050463-1	Original release.	Aug. 23, 2021

B U R E A U V E R I TAS

1 Certificate of Conformity

Product:	Fanless AI Computing System	
Brand:	Vecow	
Test Model:	EVS-2000	
Series Model:	EVS-2XXXXXXXXXXXXXXXX	
	("X" can be 0-9, A-Z or blank for marketing purposes)	
Sample Status:	Engineering sample	
Applicant:	Vecow Co., Ltd.	
Test Date:	May 18 to Aug. 11, 2021	
<u>Ctondordo</u>	EN 50155:2017, Clause 13.4.8	
Standards:	EN 50155.2017, Clause 15.4.0	
Standards:	EN 61000-3-2:2014, Class D	
Standards:		
Standards:	EN 61000-3-2:2014, Class D	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 50121-1:2017	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 50121-1:2017 EN 50121-3-2:2016	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 50121-1:2017 EN 50121-3-2:2016 EN 61000-4-2:2009	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 50121-1:2017 EN 50121-3-2:2016 EN 61000-4-2:2009 EN 61000-4-3:2006 +A1:2008 +A2:2010	
Standards:	EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 50121-1:2017 EN 50121-3-2:2016 EN 61000-4-2:2009 EN 61000-4-3:2006 +A1:2008 +A2:2010 EN 61000-4-4:2012	

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :

Date: Aug. 23, 2021

Vivian Chen / Specialist

Approved by :

Date: Aug. 23, 2021

Approved by .

Jim Hsiang / Associate Technical Manager



2 Summary of Test Results

EN 50121-3-2:2016, Emission requirements,					
EN 50155:2017, Clause 13.4.8					
Port	Result/Remarks	Verdict			
Auxiliary a.c. or d.c. power ports - Auxiliary supply sinusoidal a.c. or d.c.	Auxiliary supply 99 dBµV quasi-peak		Pass		
Auxiliary a.c. or d.c. power ports – AC power outlet port for public use	Conducted disturbance 50 Hz- 2 kHz: THD <8% (THD: total harmonic distortion)	Test not applicable because the port does not exist.	N/A		
Battery referenced ports - Battery power supply	Conducted disturbance 150 kHz- 500 kHz: 99 dBµV quasi-peak 500 kHz- 30 MHz: 93 dBµV quasi-peak	Test not applicable because the port does not exist.	N/A		
Enclosure	Radiated disturbance 30 MHz- 230 MHz: 40 dBµV/m quasi-peak 230 MHz -1 GHz: 47 dBµV/m quasi-peak	Minimum passing margin is -3.63 dB at 38.56 MHz	Pass		
Enclosure	Radiated disturbance 1 GHz- 3 GHz: 76 dBµV/m peak 56 dBµV/m average 3 GHz - 6 GHz: 80 dBµV/m peak 60 dBµV/m average	Minimum passing margin is -8.09 dB at 5400.02 MHz	Pass		

Emission requirements					
Standard Test Item / specifications Result/Remarks					
EN 61000-3-2:2014	Harmonic current emissions	Class D	Pass		
EN 61000-3-3:2013	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_c \leqq 3.3\% \\ T_{max} \leqq 500 ms \end{array}$	Pass		



	EN 50121-3-2:2016, Immunity requirements, EN 50155:2017, Clause 13.4.8					
Table Basic standard Port			Test Item / specifications	Result/Remarks	Verdict	
3.1	EN 61000-4-6:2014 +AC:2015	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass	
3.2	EN 61000-4-4:2012	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV Performance Criterion A	Performance Criterion A	Pass	
3.3	EN 61000-4-5:2014 +A1:2017	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Surges 1.2/50 (8/20) $(T_f/T_d) \mu s$ Line to ground: $\pm 2kV 42 \Omega$, 0.5 μF Line to line: $\pm 1kV 42 \Omega$, 0.5 μF Performance Criterion B	Performance Criterion A	Pass	
4.1	EN 61000-4-6:2014 +AC:2015	Signal & communication, process measurement & control ports	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass	
4.2	EN 61000-4-4:2012	Signal & communication, process measurement & control ports	Fast Transients (EFT) 5/50 (t _r /t _w) ns, 5kHz ±2kV, Capacitive clamp Performance Criterion A	Performance Criterion A	Pass	
5.1	EN 61000-4-3:2006 +A1:2008 +A2:2010	Enclosure ports	Radio-frequency electromagnetic field amplitude modulated (RS) ¹ , 80% AM (1kHz) 80-800 MHz, 20V/m Performance Criterion A	Performance Criterion A	Pass	
5.2	EN 61000-4-3:2006 +A1:2008 +A2:2010	Enclosure ports	Radio-frequency electromagnetic field from digital mobile telephones (RS) ² , 80% AM (1kHz) 800-1000 MHz, 20V/m 1400-2000 MHz, 20V/m 2000-2700 MHz, 5V/m 5100-6000 MHz, 3V/m Performance Criterion A	Performance Criterion A	Pass	



EN 50121-3-2:2016, Immunity requirements, EN 50155:2017, Clause 13.4.8							
Table Clause	Table Basic standard Port Test Item / specifications Result/Remarks Verdict						
5.3	EN 61000-4-2:2009	Enclosure ports	Electrostatic Discharges (ESD) ±6kV Contact discharge ±8kV Air discharge Performance Criterion B	Performance Criterion B	Pass		
Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.							

Note 2: For large apparatus (e.g. traction drives, auxiliary converters) it is often not practical to perform the immunity test to radiated electromagnetic fields on the complete unit. In such cases the manufacturer should test susceptible sub-systems (e.g. control electronics). The test report should justify the selection or not of sub-systems and any assumptions made (e.g. reduction of field due to case shielding).

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.

The above EN basic standards are applied with latest version if customer has no special requirement.
Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

4. N/A: Not Applicable



2.1 Performance Criteria

General Performance Criteria

The general performance criteria apply for those ports for which no specific performance criteria are defined (e.g. auxiliary ports) in the report.

Performance criterion A: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended..

Performance criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted disturbance at mains port using AMN, 150kHz ~ 30MHz	3.00 dB	3.4 dB (U _{cispr})
Radiated disturbance, 30MHz ~ 1GHz	4.30 dB	6.3 dB (<i>U</i> _{cispr})
Radiated disturbance, 1GHz ~ 6GHz	4.96 dB	5.2 dB (<i>U</i> _{cispr})

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

2.3 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 Description of EUT

Product	Fanless AI Computing System
Brand	Vecow
Test Model	EVS-2000
Carias Madal	EVS-2XXXXXXXXXXXXXXXX
Series Model	("X" can be 0-9, A-Z or blank for marketing purposes)
Model Difference	For marketing purpose
Sample Status	Engineering sample
Operating Software	Windows 10, Burnintest
Power Supply Rating	DC from Adapter
Accessory Device	N/A
Data Cable Supplied	N/A
Data Cable Supplied	N/A

Note:

The EUT uses following adapter.

Brand	MW			
Model GST280A24-C6P				
Input Power	100-240Vac, 4.5A, 50/60Hz			
Output Power 24Vdc, 41.67A, 280W				
Deveeting	AC 3Pin Non-shielded			
Power Line	DC cable (1.5m) with one ferrite core.			

3.2 Features of EUT

- 1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
- 2. The EUT was configured with the following key components:

Components	Brand	Model	Specification
CPU	Intel	i9-10900E	2.8GHz
GPU	NVIDIA	GeForce RTX 2080	-
RAM	Kingston	KVR21S15S8/8 1.2V	DDR4 2666 8GB
SSD	Innodisk	-	2.5" SATA SSD 3ME4 128GB



3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- The EUT is designed with AC power of rating 100-240Vac, 50-60Hz. For radiated emission evaluation, 230Vac/50Hz (for EN 50155), 120Vac/60Hz (for FCC Part 15) had been covered during the pre-test. The worst data was found at 230Vac/50Hz and recorded in the applied test report.
- 2. EUT has been pre-tested under following test modes, and test **mode 2** was the worst case for final test.

Mode	Test Condition
1	Display* 5: 3840*2160, 60Hz + DVI: 1920*1200, 60Hz
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz

3. Test modes are presented in the report as below.

Mode	Test Condition	Input Power					
	Conducted emission test						
2	2 Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz 23						
	Radiated emission test						
2 Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz 230Vac/ 50							
	Harmonics & Flicker and Immunity tests						
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz	230Vac/ 50Hz					



3.4 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDDs.
- d. EUT sent and received messages to/from Notebook PCs (kept in a remote area) via two UTP LAN cables (10m each).
- e. EUT sent "H" messages to ext. LCD Monitors. Then they displayed "H" messages on their screens simultaneously.
- f. EUT sent messages to printer and printer printed them out.
- g. EUT sent "1kHz" audio signal to earphone.
- h. Steps c-g were repeated.

Harmonics, Flicker, Immunity tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDDs.
- d. EUT sent and received messages to/from Notebook PCs (kept in a remote area) via two UTP LAN cables (10m each).
- e. EUT sent "color bars" messages to ext. LCD Monitors. Then they displayed "color bars" messages on their screens simultaneously.
- f. EUT sent audio signal to speaker.
- g. Steps c-f were repeated.

3.5 Primary Clock Frequencies of Internal Source

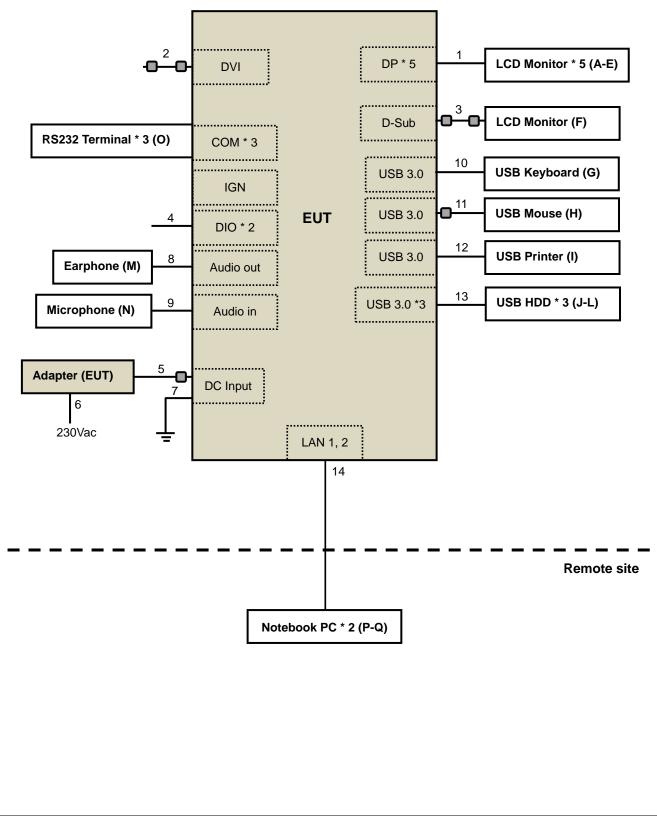
The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 2.8GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.



4 Configuration and Connections with EUT

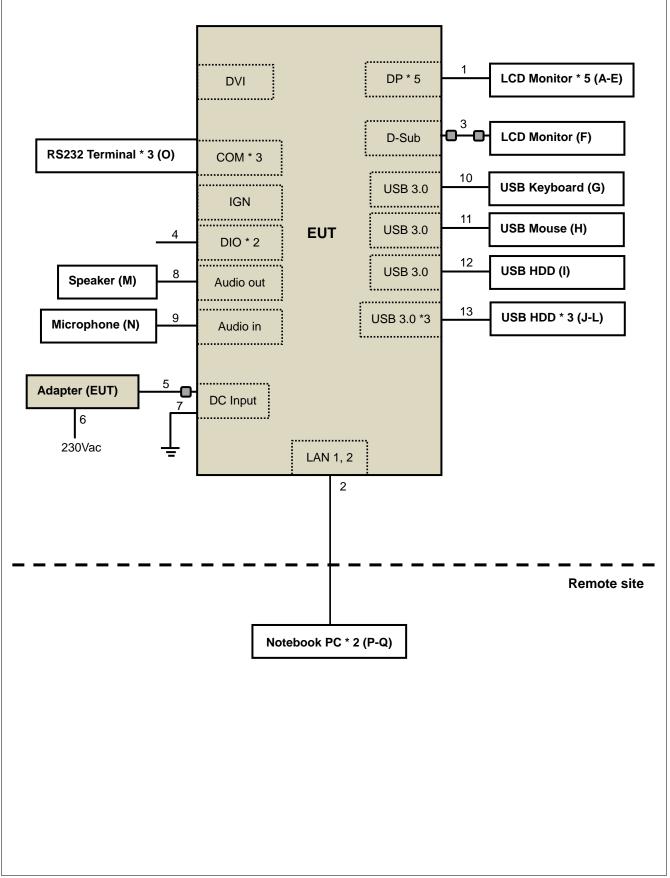
4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):











4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks			
Α.	LCD MONITOR	ASUS	VG289Q	M1LMTF385740	NA	Provided by Lab			
В.	LCD MONITOR	ASUS	VG289Q	M1LMTF385742	NA	Provided by Lab			
C.	LCD MONITOR	ASUS	VG289Q	M1LMTF385752	NA	Provided by Lab			
D.	LCD MONITOR	ASUS	VG289Q	M1LMTF385832	NA	Provided by Lab			
Ε.	LCD MONITOR	ASUS	MX27U	K1LMRS022996	NA	Provided by Lab			
F.	LCD MONITOR	DELL	U2410	CN082WXD728720C C0HLL	FCC DoC Approved	Provided by Lab			
G.	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300- 7CL-1909	NA	Provided by Lab			
Η.	USB Mouse	Microsoft	1113	9170528318308	FCC DoC Approved	Provided by Lab			
١.	USB Printer	HP	HP Officejet Pro 251dw	CN55FCV012	FCC DoC Approved	Provided by Lab			
J.	USB 3.1 Hard Disk	Transcend	SSD220S	SK21D1718X00A7	FCC DoC Approved	Provided by Lab			
K.	USB 3.1 Hard Disk	Transcend	SSD220S	SK21D1718X008N	FCC DoC Approved	Provided by Lab			
L.	USB-C Hard Disk	G-DRIVE	0G04878	620XJ6RW	FCC DoC Approved	Provided by Lab			
М.	EARPHONE	PHILIPS	SBC HL145	N/A	NA	Provided by Lab			
Ν.	MICROPHONE	Labtec	mic-333	N/A	NA	Provided by Lab			
Ο.	RS232 Terminal* 3	NA	NA	NA	NA	Supplied by client			
Ρ.	Notebook PC	LENOVO	T480	PF1EZSAW	NA	Provided by Lab			
Q.	Notebook PC	LENOVO	T480	PF1EZSA2	NA	Provided by Lab			
Noto									

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Items P-Q acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DP cable	5	1.8	Y	0	Provided by Lab
2.	DVI cable	1	1.8	Y	2	Provided by Lab
3.	D-Sub cable	1	1.8	Y	2	Provided by Lab
4.	Signal cable	2	0.3	Ν	0	Provided by Lab
5.	DC power cable	1	1.5	Ν	1	Supplied by client
6.	AC power cable	1	1.5	Ν	0	Supplied by client
7.	GND cable	1	1.6	Ν	0	Provided by Lab
8.	Audio cable	1	2.0	Ν	0	Provided by Lab
9.	Audio cable	1	1.5	Ν	0	Provided by Lab
10.	USB cable	1	1.8	Y	0	Provided by Lab
11.	USB cable	1	1.8	Y	1	Provided by Lab
12.	USB cable	1	1.5	Y	0	Provided by Lab
13.	USB cable	3	1.0	Y	0	Provided by Lab
14.	LAN cable	2	10	Y	0	Provided by Lab (RJ45, Cat.5e)

Note: The core(s) is(are) originally attached to the cable(s).



ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100-9 5R-05KB	NA	Provided by Lab
В.	LCD MONITOR	DELL	P2415Qb	CN-OGTTPW-74261- 662-OAGL	NA	Provided by Lab
C.	LCD MONITOR	DELL	P2415Qb	CN-OGTTPW-74261- 662-OAAL	NA	Provided by Lab
D.	LCD MONITOR	DELL	P2418HZM	CN-079XVV-TV200-8 BG-00NT	NA	Provided by Lab
E.	LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100-9 75-090U	NA	Provided by Lab
F.	LCD MONITOR	DELL	S2316Hc	NA	NA	Provided by Lab
G.	USB Keyboard	HP	KU1516	NA	NA	Provided by Lab
Η.	USB Mouse	HP	M-UAE96	F93A90AN3V42GQ5	FCC DoC Approved	Provided by Lab
١.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421116	NA	Provided by Lab
J.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887420071	NA	Provided by Lab
К.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421083	NA	Provided by Lab
L.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421404	NA	Provided by Lab
Μ.	Speaker	NA	NA	NA	NA	Provided by Lab
Ν.	MICROPHONE	NA	NA	NA	NA	Provided by Lab
Ο.	RS232 Terminal* 3	NA	NA	NA	NA	Supplied by client
Ρ.	Notebook PC	Lenovo	T470	PF-0QW0NQ	NA	Provided by Lab
Q.	Notebook PC	Lenovo	L460	PF0PLHDU	NA	Provided by Lab

Harmonics, Flicker, Immunity tests:

Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Items P-Q acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DP cable	5	1.8	Y	0	Provided by Lab
2.	LAN cable	2	10	Y	0	Provided by Lab (RJ45, Cat.5e)
3.	D-Sub cable	1	1.8	Y	2	Provided by Lab
4.	Signal cable	2	0.3	Ν	0	Provided by Lab
5.	DC power cable	1	1.5	Ν	1	Supplied by client
6.	AC power cable	1	1.5	Ν	0	Supplied by client
7.	GND cable	1	1.0	Ν	0	Provided by Lab
8.	Audio cable	1	1.0	Ν	0	Provided by Lab
9.	Audio cable	1	1.0	Ν	0	Provided by Lab
10.	USB cable	1	1.8	Y	0	Provided by Lab
11.	USB cable	1	1.8	Y	0	Provided by Lab
12.	USB cable	1	0.6	Y	0	Provided by Lab
13.	USB cable	3	0.3	Y	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).



5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports

5.1 Limits

Frequency (MHz)	Quasi-peak, (dBuV)
0.15 - 0.5	99
0.5 - 30	93

Notes: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

5.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE &SCHWARZ TEST RECEIVER	ESCS 30	838251/021	Nov. 3, 2020	Nov. 2, 2021
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101196	Apr. 26, 2021	Apr. 25, 2022
LISN With Adapter(for EUT)	101196	NA	Apr. 26, 2021	Apr. 25, 2022
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 28, 2020	Jul. 27, 2021
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 20, 2021	May 19, 2022
SCHWARZBECK Artificial Mains Network (for EUT)	NNLK 8121	8121-808	Apr. 18, 2021	Apr. 17, 2022
Software	Cond_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With10dB PAD	5D-FB	Cable-C03-01	Sep. 16, 2020	Sep. 15, 2021
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 27, 2021	Jan. 26, 2022
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 27, 2021	Jan. 26, 2022

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in Shielded Room No. 3. (Conduction 3)

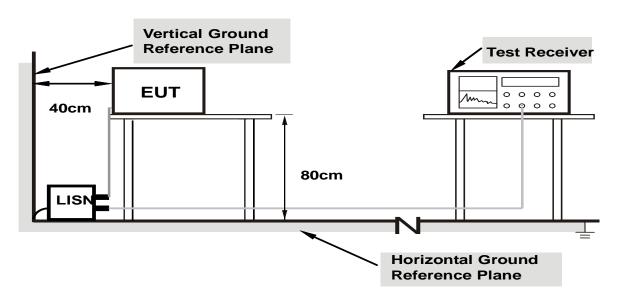
3. The VCCI Site Registration No. C-10274.

4. Tested Date: May 24, 2021



5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.
- Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: Support units were connected to second LISN.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230Vac 50Hz	Environmental Conditions	25℃, 70%RH
Tested by	Adam Chen	Test Date	2021/5/24
Test Mode	Mode 2		

	Phase Of Power : Line (L)								
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)			
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.			
1	0.23203	9.70	33.33	43.03	99.00	-55.97			
2	0.46250	9.71	28.08	37.79	99.00	-61.21			
3	0.69297	9.71	29.58	39.29	93.00	-53.71			
4	3.58984	9.83	38.14	47.97	93.00	-45.03			
5	7.17969	9.87	34.55	44.42	93.00	-48.58			
6	10.76563	9.91	31.43	41.34	93.00	-51.66			
7	16.94922	9.95	35.30	45.25	93.00	-47.75			

Remarks:

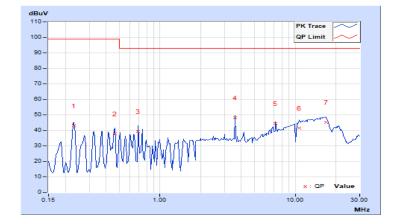
1. Q.P. and AV. are abbreviations of quasi-peak and average individually.

2. The emission levels of other frequencies were very low against the limit.

3. Margin value = Emission level - Limit value

4. Correction factor = Insertion loss + Cable loss

5. Emission Level = Correction Factor + Reading Value



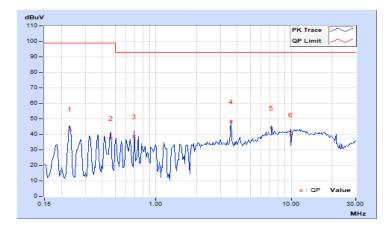


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	25℃, 70%RH
Tested by	Adam Chen	Test Date	2021/5/24
Test Mode	Mode 2		

	Phase Of Power : Neutral (N)								
No	Frequency	Correction Factor	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)			
	(MHz)	(dB)	Q.P.	Q.P.	Q.P.	Q.P.			
1	0.23203	9.70	33.77	43.47	99.00	-55.53			
2	0.46250	9.71	27.78	37.49	99.00	-61.51			
3	0.69297	9.72	28.63	38.35	93.00	-54.65			
4	3.58984	9.83	38.14	47.97	93.00	-45.03			
5	7.17969	9.88	34.31	44.19	93.00	-48.81			
6	9.97656	9.91	29.77	39.68	93.00	-53.32			

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





6 Radiated Disturbance up to 1 GHz

6.1 Limits

Frequency (MHz)	dBuV/m (at 10m) / quasi-peak
30 - 230	40
230 - 1000	47

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level $(dBuV/m) = 20 \log Emission level (uV/m)$.

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

6.2 Test Instruments

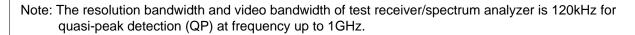
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100292	Aug. 26, 2020	Aug. 25, 2021
Schwarzbeck Bilog Antenna	VULB9168	9168-303	Nov. 5, 2020	Nov. 4, 2021
Agilent Preamplifier	8447D	2944A08119	Feb. 18, 2021	Feb. 17, 2022
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ADT RF Switches BOX	EMH-011	1001	Oct. 23, 2020	Oct. 22, 2021
Pacific RF cable With 5dB PAD	8D	CABLE-ST2-01	Oct. 23, 2020	Oct. 22, 2021

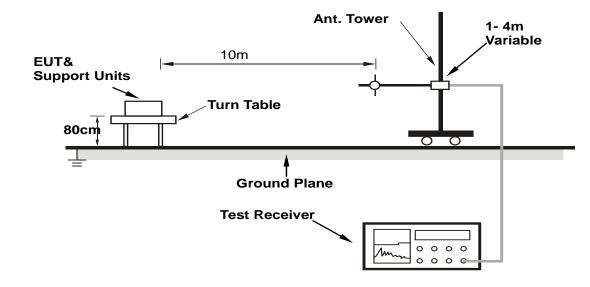
- Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 - 2. The test was performed in Open Site No. 2.
 - 3. The VCCI Site Registration No. R-10237.
 - 4. Tested Date: May 27, 2021



6.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



6.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	ED. Lin	Environmental Conditions	29.0℃, 62.0%RH
Test Mode	Mode 2	Test Date	2021/5/27

	Antenna Polarity & Test Distance : Horizontal at 10 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	82.54	32.87 QP	40.00	-7.13	4.00 H	145	48.30	-15.43
2	200.00	35.50 QP	40.00	-4.50	4.00 H	230	47.80	-12.30
3	218.98	33.91 QP	40.00	-6.09	4.00 H	61	45.74	-11.83
4	506.53	38.93 QP	47.00	-8.07	1.93 H	360	42.26	-3.33
5	624.25	38.58 QP	47.00	-8.42	1.89 H	266	39.16	-0.58
6	648.25	40.31 QP	47.00	-6.69	1.97 H	97	40.64	-0.33
7	672.25	41.45 QP	47.00	-5.55	1.51 H	349	41.54	-0.09
8	744.25	37.76 QP	47.00	-9.24	1.00 H	20	35.77	1.99

Remarks:

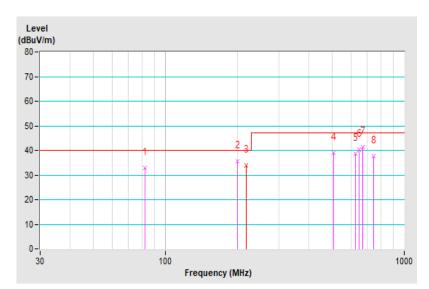
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	ED. Lin	Environmental Conditions	29.0℃, 62.0%RH
Test Mode	Mode 2	Test Date	2021/5/27

	Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	38.56	36.37 QP	40.00	-3.63	1.00 V	163	46.91	-10.54	
2	65.91	33.69 QP	40.00	-6.31	1.72 V	286	45.19	-11.50	
3	94.21	33.14 QP	40.00	-6.86	1.00 V	192	48.32	-15.18	
4	114.41	33.08 QP	40.00	-6.92	1.00 V	198	45.33	-12.25	
5	152.22	32.75 QP	40.00	-7.25	1.00 V	7	42.03	-9.28	
6	215.01	34.86 QP	40.00	-5.14	1.00 V	147	46.85	-11.99	
7	672.21	39.35 QP	47.00	-7.65	2.19 V	120	39.44	-0.09	
8	1000.00	39.23 QP	47.00	-7.77	1.89 V	264	32.63	6.60	

Remarks:

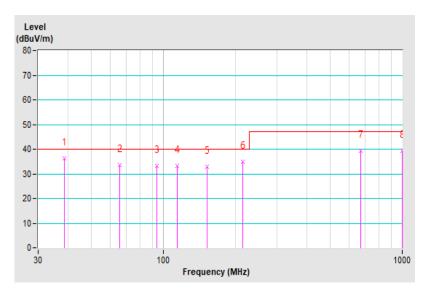
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





7 Radiated Disturbance above 1 GHz

7.1 Limits

Fraguanay (CHz)	dBuV/m (at 3m)			
Frequency (GHz)	Average	Peak		
1 to 3	56	76		
3 to 6	60	80		

Notes: 1. The lower limit shall apply at the transition frequencies.

2. Emission level (dBuV/m) = 20 log Emission level (uV/m).

3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

7.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 23, 2020	Jun. 22, 2021
R&S Test Receiver	ESR3	102412	Jan. 29, 2021	Jan. 28, 2022
EMCI Preamplifier	EMC0126545	980076	Feb. 19, 2021	Feb. 18, 2022
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 19, 2021	Feb. 18, 2022
EMCI Preamplifier	EMC184045B	980235	Feb. 19, 2021	Feb. 18, 2022
ETS Preamplifier	3117-PA	00215857	Nov. 23, 2020	Nov. 22, 2021
Schwarzbeck Horn Antenna	BBHA-9170	212	Nov. 22, 2020	Nov. 21, 2021
EMCO Horn Antenna	3115	9312-4192	Nov. 22, 2020	Nov. 21, 2021
Max Full. Turn Table & Tower	MF7802	MF780208103	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH7-3.6m	Jul. 9, 2020	Jul. 8, 2021
MICRO-TRONICS Notch filter	BRC50703-01	010	May 29, 2020	May 28, 2021
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 29, 2020	May 28, 2021

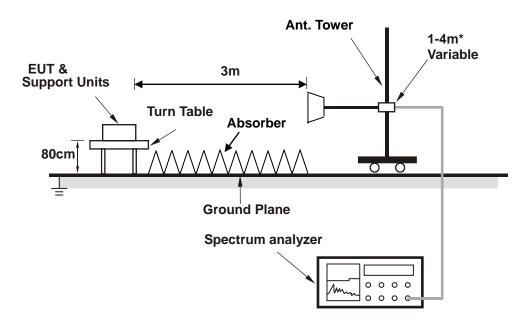
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The 3dB beamwidth of the horn antenna is minimum 40 degree (or w = 2.18m at 3m distance) for 1~6 GHz.
- 3. The test was performed in Chamber No. 7.
- 4. The VCCI Site Registration No. G-10039
- 5. Tested Date: May 18, 2021



7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.
- Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



7.4 Test Results

Frequency Range	1GHz ~ 6GHz		Peak (PK) / Average (AV), 1MHz
Tested By	Vincent Lin	Environmental Conditions	23.0℃, 67.0%RH
Test Mode	Mode 2	Test Date	2021/5/18

	Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	1467.08	54.16 PK	76.00	-21.84	1.00 H	114	57.63	-3.47	
2	1467.08	39.23 AV	56.00	-16.77	1.00 H	114	42.70	-3.47	
3	2756.87	54.81 PK	76.00	-21.19	1.48 H	131	54.70	0.11	
4	2756.87	41.84 AV	56.00	-14.16	1.48 H	131	41.73	0.11	
5	5400.02	58.40 PK	80.00	-21.60	1.06 H	192	51.33	7.07	
6	5400.02	49.72 AV	60.00	-10.28	1.06 H	192	42.65	7.07	

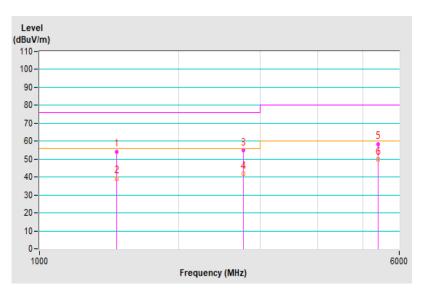
Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





F actor B and B a	11(-H7 ~ 6(-H7	Detector Function &	Peak (PK) / Average (AV),
Frequency Range		Resolution Bandwidth	1MHz
Tested Dy	Vincent Lin	Environmental	22.0°C 67.0% DH
Tested By		Conditions	23.0℃, 67.0%RH
Test Mode	Mode 2	Test Date	2021/5/18

	Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	1594.67	61.50 PK	76.00	-14.50	1.00 V	230	64.70	-3.20	
2	1594.67	43.63 AV	56.00	-12.37	1.00 V	230	46.83	-3.20	
3	4994.91	54.35 PK	80.00	-25.65	2.18 V	177	48.66	5.69	
4	4994.91	36.88 AV	60.00	-23.12	2.18 V	177	31.19	5.69	
5	5400.02	58.71 PK	80.00	-21.29	1.81 V	224	51.64	7.07	
6	5400.02	51.91 AV	60.00	-8.09	1.81 V	224	44.84	7.07	

Remarks:

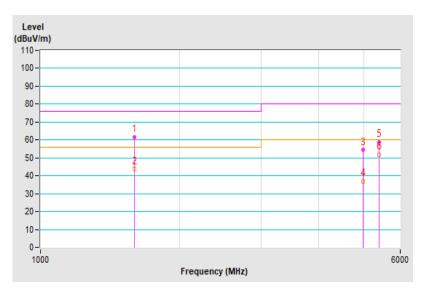
1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)

- Pre-Amplifier Factor (dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value





8 Harmonics Current Measurement

8.1 Limits

Limits fo	or Class A equipment		Limits for Class D equi	pment
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current
n	A	n	watt mA/W	A
	Odd harmonics		Odd Harmonics on	у
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n
E	ven harmonics			
2	1.08			
4	0.43			
6	0.30			
8≦n≦40	0.23 x 8/n			

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

 According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

8.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D;	equipment which is		W of the following types:
Tools excluding portable tools;	not professional		Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;			Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

8.3 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

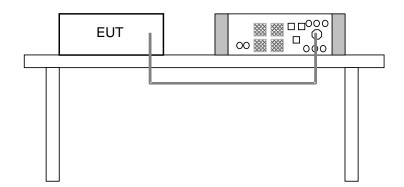
2. The test was performed in EMS Room No. 1.

3. Tested Date: May 31, 2021



8.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.5 Test Results

	230.56Vrms/ 0.756Arms	Power Frequency	50.00Hz
Power Consumption	158.8W	Power Factor	0.942
Environmental Conditions	24°C, 80% RH	Tested by	Xun Lee
Test Mode	Mode 2	Test Date	2021/5/31

Harm #	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)	Test Result
3	0.065	0.540	0.066	0.810	Pass
5	0.022	0.302	0.023	0.453	Pass
7	0.020	0.159	0.020	0.238	Pass
9	0.016	0.079	0.016	0.119	Pass
11	0.014	0.056	0.014	0.083	Pass
13	0.012	0.048	0.012	0.071	Pass
15	0.008	0.041	0.009	0.062	Pass
17	0.006	0.037	0.007	0.055	Pass
19	0.004	0.032	0.005	0.048	Pass
21	0.007	0.029	0.009	0.044	Pass
23	0.009	0.027	0.011	0.040	Pass
25	0.005	0.024	0.006	0.037	Pass
27	0.006	0.023	0.008	0.034	Pass
29	0.004	0.021	0.005	0.032	Pass
31	0.003	0.020	0.004	0.030	Pass
33	0.003	0.018	0.004	0.028	Pass
35	0.004	0.017	0.004	0.026	Pass
37	0.004	0.017	0.004	0.025	Pass
39	0.003	0.016	0.003	0.024	Pass

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



9 Voltage Fluctuations and Flicker Measurement

9.1 Limits

Test item	Limit	Note
Pst	1.0	Pst: short-term flicker severity.
Plt	0.65	Plt: long-term flicker severity.
T _{max} (ms)	500	$T_{max:}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d _c .
d _{max} (%)	4	d _{max:} maximum absolute voltage change during an observation period.
d _c (%)	3.3	dc maximum steady state voltage change during an observation period.

9.2 Test Instruments

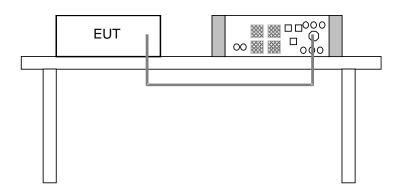
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. Tested Date: May 31, 2021

9.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



9.4 Test Results

Fundamental Voltage/Ampere	230.56Vrms/ 0.756Arms	Power Frequency	50.00Hz
Observation (T _p)	10 min.	Power Factor	0.942
Enviromental Conditions	24°C, 80% RH	Tested by	Xun Lee
Test Mode	Mode 2	Test Date	2021/5/31

Test Parameter	Measurement Value	Limit	Remarks
Pst	0.319	1.00	Pass
Pıt	0.139	0.65	Pass
T _{max} (ms)	0	500	Pass
d _{max} (%)	0	4	Pass
d _c (%)	0	3.3	Pass

Note: (1) Pst means short-term flicker indicator.

(2) Plt means long-term flicker indicator.

(3) T_{max} means accumulated time value of d(t) with a deviation exceeding 3.3 %.
(4) d_{max} means maximum relative voltage change.

(5) d_c means maximum relative steady-state voltage change.

10 Electrostatic Discharge Immunity Test (ESD)

10.1 Test Specification	
Basic Standard:	EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: ±2, ±4, ±8kV (Direct) Contact Discharge: ±2, ±4, ±6kV (Indirect & Direct)
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

10.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0504259	Nov. 6, 2020	Nov. 5, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in ESD Room No. 1.

3. Tested Date: Jun. 2, 2021

10.3 Test Arrangement

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

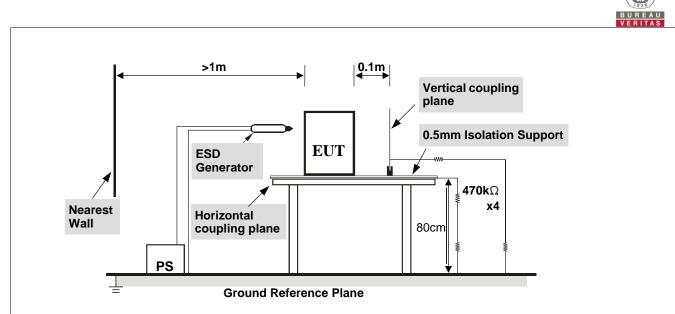


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940k Ω total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



10.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Kent Wang	
Environmental conditions	23 °C, 47% RH 1002 mbar	Test Date	2021/6/2	
Test mode	Mode 2			

Test Results of Direct Application						
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion	
2, 4	+/-	1-3, 11	Note 1	NA	А	
6	+/-	1-3, 11	Note 2, 3	NA	В	
2, 4, 8	+/-	4-7, 12, 13	NA	Note 1	А	
2, 4	+/-	8-10	NA	Note 1	А	
8	+/-	8-10	NA	Note 2, 3	В	

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application							
Discharge	Polarity	Test Point	Horizontal	Vertical Coupling	Performance		
Level (kV)	(+/-)	Test Follit	Coupling Plane	Plane	Criterion		
2, 4, 6	+/-	Four Sides	Note 1	Note 1	А		
Description of test points of indirect application:							

Description of test points of indirect application:

1. Front side

2. Rear side

3. Right side

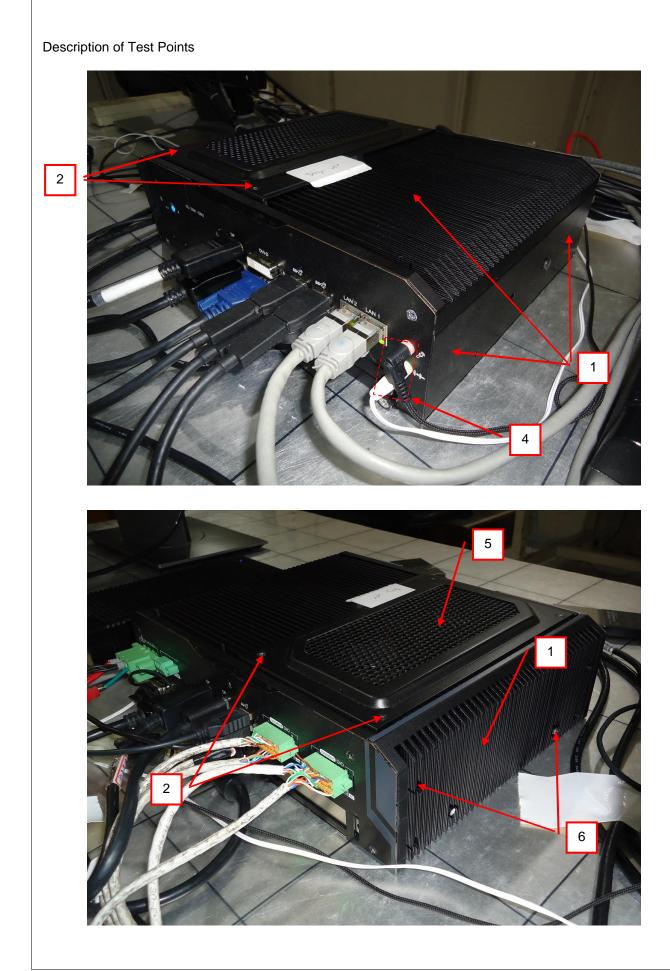
4. Left side

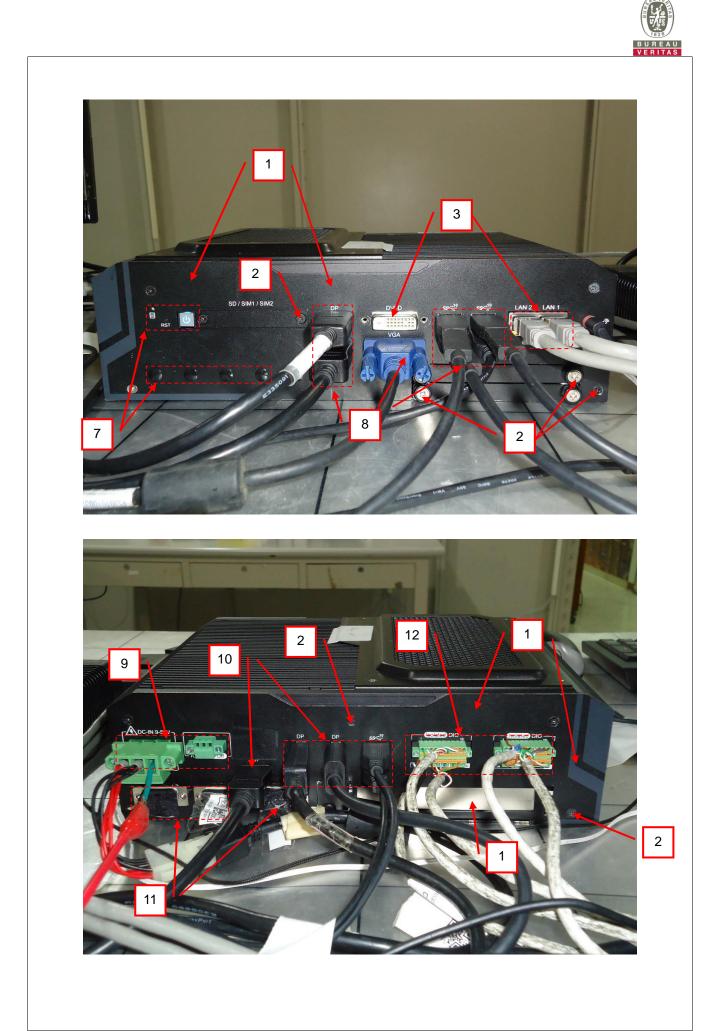
Note: 1. The EUT function was correct during the test.

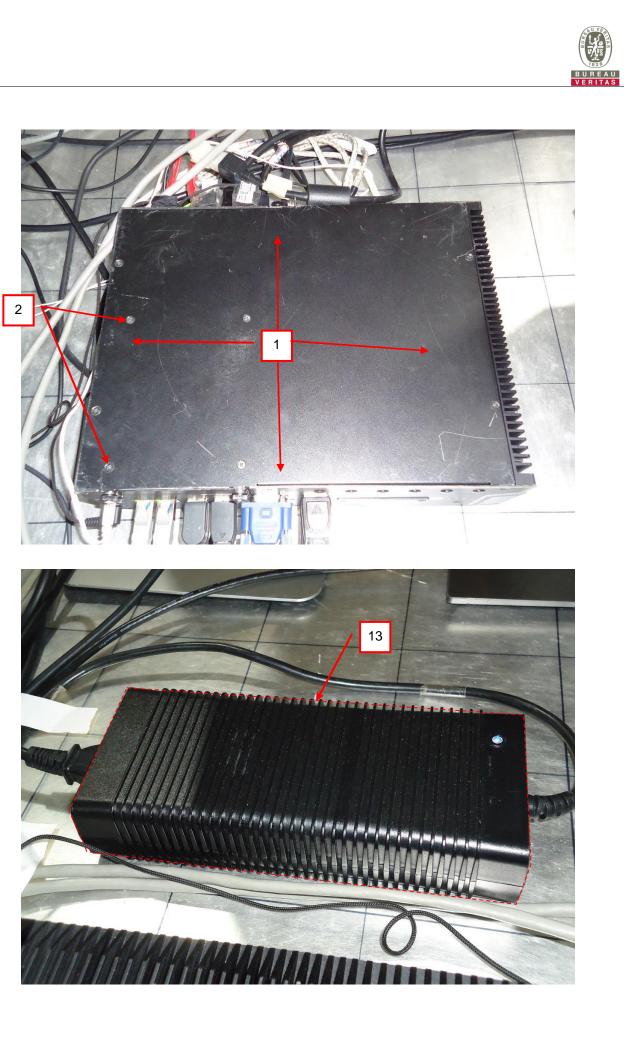
2. The image on the screen disappeared during the test, but self-recoverable after the test.

3. R/W function was delayed 1-2 seconds during the test, but could self-recover after the test.









11 Radio-frequency Electromagnetic Field Immunity Test (RS)

11.1 Test Specification

Basic Standard:	EN 61000-4-3		
	80-800 MHz, 20V/m ¹		
Fraguency Bongo Field	800-1000 MHz, 20V/m		
Frequency Range, Field Strength:	1400-2000 MHz, 10V/m		
	2000-2700 MHz, 5V/m		
	5100-6000 MHz, 3V/m		
Modulation:	1kHz Sine Wave, 80%, AM Modulation		
Frequency Step:	1 % of preceding frequency value		
Polarity of Antenna:	Horizontal and Vertical		
Antenna Height:	1.5m		
Dwell Time:	3 seconds		

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
R&S Signal Generator	SMJ100A	101925	Sep. 2, 2020	Sep. 1, 2021
BONN RF Amplifier	BSA 0125-800	1912556	NA	NA
TESTQAmplifier	CBA 1G-275	T44344	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
ARLog-Periodic Antenna	AT6080	0329465	NA	NA
BOONTON RF Voltage Meter	4232A	10180	May 24, 2021	May 23, 2022
BOONTON Power Sensor	51011-EMC	34152	May 24, 2021	May 23, 2022
BOONTON Power Sensor	51011-EMC	34153	May 24, 2021	May 23, 2022
EMCO BiconiLog Antenna	3141	1001	NA	NA
ARHigh Gain Antenna	AT4010	0329800	NA	NA
SchwarzbeckLOG ANTENNA	Stlp 9149	9149-260	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 4, 2021	Feb. 3, 2022
Software	RS_V7.6	NA	NA	NA

11.2 Test Instruments

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in RS Room No.2.
- 3. Tested Date: May 31, 2021



The test procedure was in accordance with EN 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency ranges and field strength levels are 80-800 MHz, 20V/m, 800-1000 MHz, 20V/m, 1400-2000 MHz, 10V/m, 2000-2700 MHz, 5V/m and 5100-6000 MHz, 3V/m with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

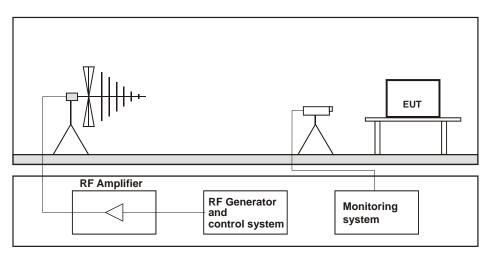


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



11.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Xun Lee
Environmental conditions	22 °C, 70% RH	Test Date	2021/5/31
Test mode	Mode 2		

Frequency			Applie	d Field Strength	Test		Performance
(MHz)	Polarity	Azimuth(°)	(V/m)	Modulation	Distance (m)	Observation	Criterion
80 - 800	V&H	0, 90, 180, 270	20	80% AM (1kHz)	3	Note	А
800 - 1000	V&H	0, 90, 180, 270	20	80% AM (1kHz)	3	Note	А
1400 - 2000	V&H	0, 90, 180, 270	10	80% AM (1kHz)	3	Note	А
2000 - 2700	V&H	0, 90, 180, 270	5	80% AM (1kHz)	3	Note	А
5100 - 6000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	3	Note	А



12 Electrical Fast Transient/Burst Immunity Test (EFT)

12.1 Test Specification

Basic Standard:	EN 61000-4-4
Test Voltage:	Signal & communication, process measurement & control ports: ±2kV, Capacitive clamp Battery referenced ports (except at the output of energy sources),
	Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms): \pm 2kV
Impulse Repetition Frequency:	5kHz
Impulse Wave Shape:	5/50 (T _r /T _h) ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

12.2 Test Instruments

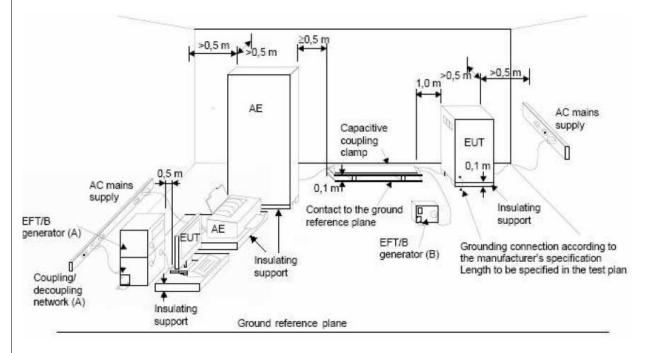
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 7, 2021	Apr. 6, 2022
Haefely,Capacitive Clamp	IP4A	155173	Apr. 7, 2021	Apr. 6, 2022

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EFT Room.
- 3. Tested Date: May 26, 2021



- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN 61000-4-4, 5/50 ns.



NOTE:

(A) location for supply line coupling

(B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



12.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Xun Lee
Environmental conditions	22 °C, 70% RH	Test Date	2021/5/26
Test mode	Mode 2		

Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	L1	+/-	Note	А
2	L2	+/-	Note	А
2	PE	+/-	Note	А
2	L1-L2-PE	+/-	Note	А

Signal & communication, process measurement & control ports

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	LAN (port 1, 2)	+/-	Note	А

13 Surge Immunity Test

13.1 Test Specification

Basic Standard: Wave-Shape:	EN 61000-4-5 Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms): 1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current
Test Voltage:	Line to line: ±0.5kV, ±1kV, Line to ground: ±0.5kV, ±1kV, ±2kV output impedance of 42 Ω (40 Ω and 2 Ω generator) and a coupling capacitance of 0,5 µF
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

13.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	Apr. 30, 2021	Apr. 29, 2022
Coupling Decoupling Network	CDN-UTP8	045	Aug. 18, 2020	Aug. 17, 2021
TESEQ Coupling Decoupling Network	CDN HSS-2	41009	Apr. 30, 2021	Apr. 29, 2022
TESEQ Coupling Decoupling Network	CDN 118-T8	40386	Sep. 8, 2020	Sep. 7, 2021
TESEQ CDN for Unshielded Unsymmetrical Signal & Data Lines	CDN117	40144	Sep. 8, 2020	Sep. 7, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

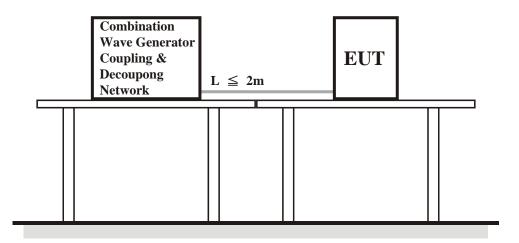
2. The test was performed in EMS Room No. 2.

3. Tested Date: Jun. 1, 2021



The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

13.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Xun Lee
Environmental conditions	22 °C, 70% RH	Test Date	2021/6/1
Test mode	Mode 2		

Battery referenced ports (except at the output of energy sources),

Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L1-L2	+/-	Note	A
0.5, 1, 2	L1-PE	+/-	Note	A
0.5, 1, 2	L2-PE	+/-	Note	A



14 Immunity to Conducted Disturbances Induced by RF Fields (CS)

14.1 Test Specification

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms), Signal & communication, process measurement & control ports: 10 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds



14.2 Test Instruments

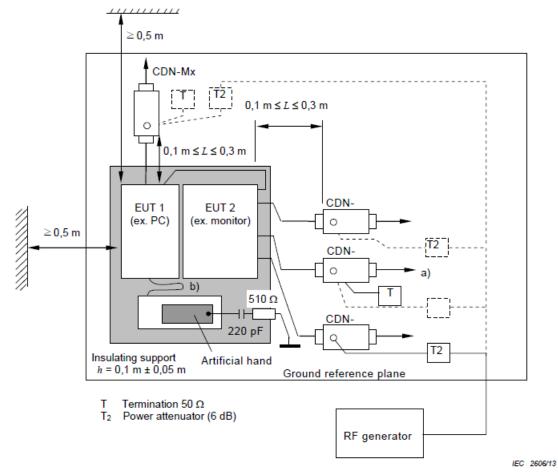
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ	SML03	101801	Jan. 13, 2021	Jan. 12, 2022
Signal Generator				
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 17, 2021	Jun. 16, 2022
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Aug. 08,2021	Aug. 07,2022
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T800	29459	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T8-230	56641 Feb. 25, 2021		Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN T8-230	56642	Feb. 25, 2021	Feb. 24, 2022
R&S Power Sensor	NRV-Z5	837878/039	Nov. 10, 2020	Nov. 9, 2021
R&S Power Meter	NRVD	837794/040	Nov. 10, 2020	Nov. 9, 2021
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T8-230	56643 Feb. 25, 2021		Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S200	53490 May 26, 2021		May 25, 2022
TESEQ Coupling Decoupling Network	CDN S400	52115	Jun. 17, 2021	Jun. 16, 2022
TESEQ Coupling Decoupling Network	CDN T400A	49918	Feb. 25, 2021	Feb. 24, 2022
FCC Coupling Decoupling Network	FCC-801-M5-50A	100018	Jan. 19, 2021	Jan. 18, 2022
TESEQ Coupling Decoupling Network	CDN T2A-10	54942	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56435	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56527	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56525	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN M432S	56519 Feb. 25, 20		Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56436	Feb. 25, 2021	Feb. 24, 2022
Software	CS_V7.4.2	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in CS Room No. 1.
- 3. Tested Date: Aug. 11, 2021



- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- **Note:** 1.The EUT clearance from any metallic obstacles shall be at least 0,5 m.
 - 2. Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.
 - 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



14.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Joey Liu
Environmental conditions	23 °C, 73% RH Test Date		2021/8/11
Test mode	Mode 2		

Frequency (MHz)	Level (V rms)	Tested Line	Injection Method	Return Path	Observation	Remark	Performance Criterion
0.15 – 80	10	AC Power	CDN-M3	CDN-M1	Note	-	A
0.15 – 80	10	LAN (port 1, 2)	CDN-ST08A	CDN-M1	Note	-	А



15 Pictures of Test Arrangements

15.1 Conducted Disturbance at Auxiliary a.c. or d.c. power ports



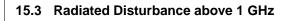


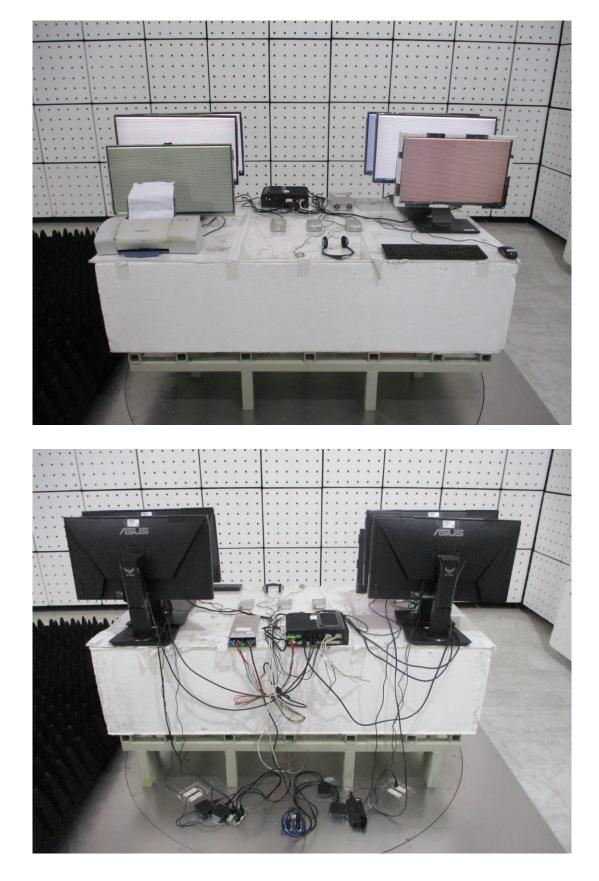


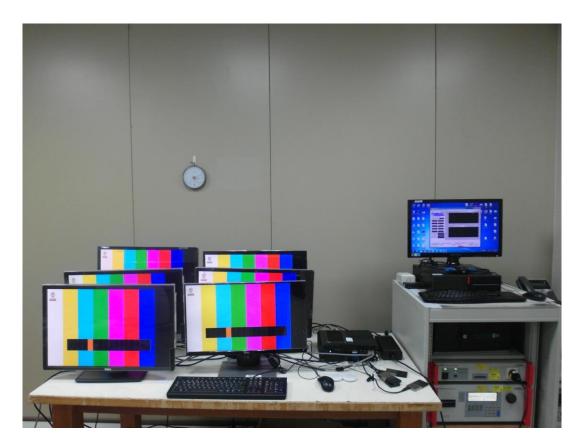
15.2 Radiated Disturbance up to 1 GHz









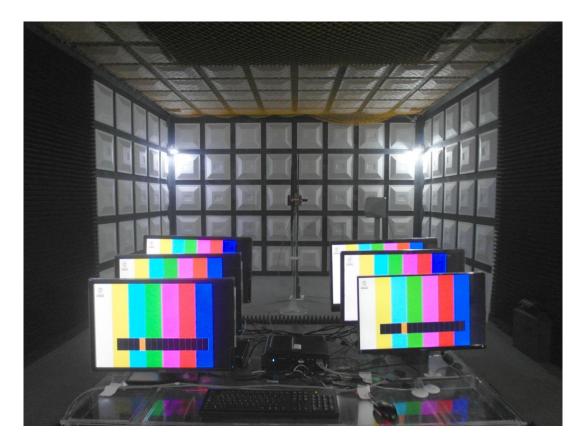


15.4 Harmonics Current, Voltage Fluctuations and Flicker Measurement

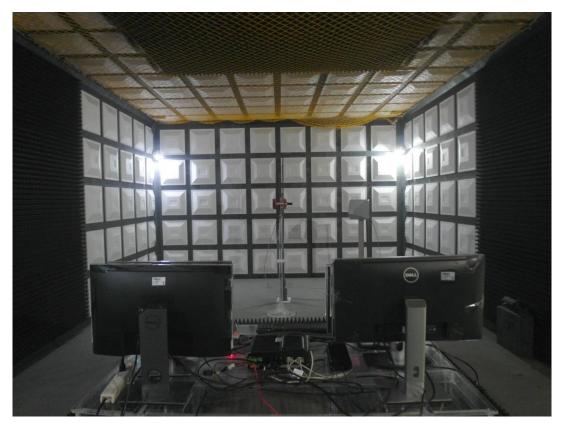
15.5 Electrostatic Discharge Immunity Test (ESD)



Report No.: CEBDBO-WTW-P21050463-1

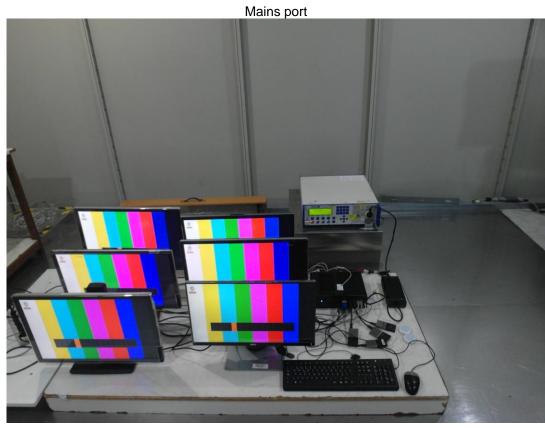




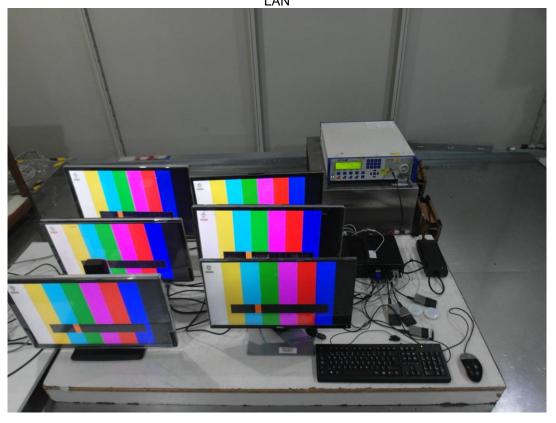




15.7 Fast Transients (EFT)

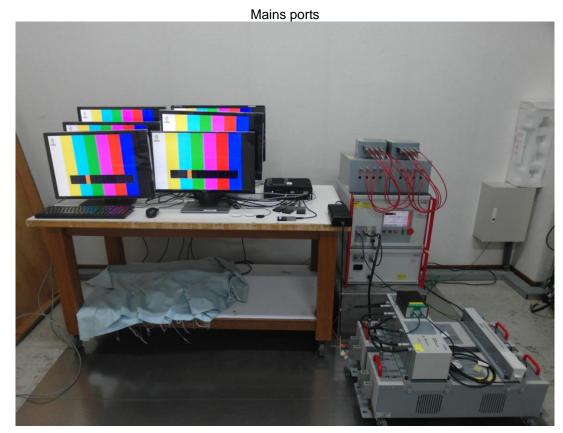




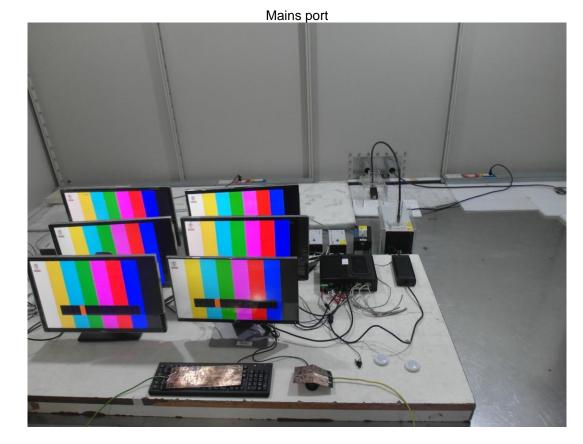




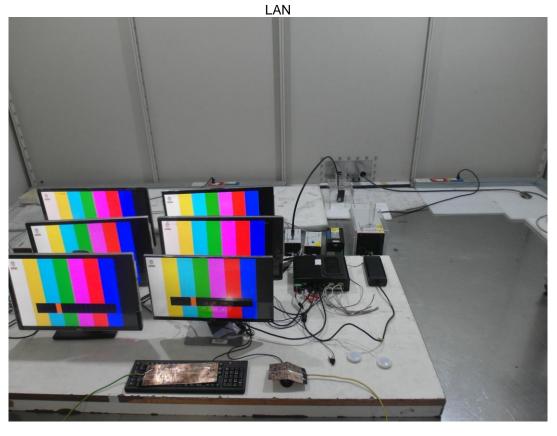
15.8 Surge







15.9 Radio-frequency common mode (CS)





Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Lin Kou EMC/RF Lab

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Email: <u>service.adt@tw.bureauveritas.com</u> Web Site: <u>www.bureauveritas-adt.com</u>

The address and road map of all our labs can be found in our web site also.

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